

30V N-Channel Enhancement Mode MOSFET

Description

The 100N03 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

V_{DS} = 30V I_D =100 A

 $R_{\text{DS(ON)}}$ < 5.5m Ω @ V_{GS}=10V $~(\text{Type: }4.5m\Omega)$

Application

Battery protection

Load switch

Uninterruptible power supply





Absolute Maximum Ratings (Tc=25°Cunless otherwise noted)

Symbol	Parameter	Max.	Units
VDSS	Drain-Source Voltage	30	V
VGSS	Gate-Source Voltage	±20	V
I ⊳@Tc=25 ℃	Continuous Drain Current, V _{GS} @ 10V	100	А
I₀@Tc=100℃	Continuous Drain Current, V _{GS} @ 10V	46	А
IDM	Pulsed Drain Current note1	300	А
EAS	Single Pulsed Avalanche Energy ^{note2}	56	mJ
P₀@T₀=25℃	Total Power Dissipation ⁴	68	W
R₀JA	Thermal Resistance Junction-ambient (Steady State) ¹	62	°C/W
R₀JA	Thermal Resistance Junction-Ambient ¹ (t \leq 10s)	25	°C /W
RθJC	Thermal Resistance, Junction to Case	2.2	°C /W
TJ, TSTG	Operating and Storage Temperature Range	-55 to +175	°C



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Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
V(BR)DSS	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	30	32	-	V
∆BVDSS/∆TJ	BVDSS Temperature Coefficient	Reference to 25°C, ID=1mA		0.028		V/°C
VGS(th)	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D =250µA	1.2	1.6	2.5	V
RDS(on)	Static Drain-Source on-Resistance note3	V _{GS} =10V, I _D =30A	-	4.5	5.5	mΩ
RDS(on)	Static Drain-Source on-Resistance note3	V _{GS} =4.5V, I _D =20A	-	8.0	9.5	mΩ
IDSS	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} = 0V,	-	-	1.0	μA
IGSS	Gate to Body Leakage Current	V _{DS} =0V, V _{GS} = ±20V	-	-	±100	nA
Ciss	Input Capacitance	V _{DS} =15V, V _{GS} =0V, f = 1.0MHz	-	1614	-	pF
Coss	Output Capacitance		-	245	-	pF
Crss	Reverse Transfer Capacitance		-	215	-	pF
Qg	Total Gate Charge		-	33.7	-	nC
Qgs	Gate-Source Charge	V _{DS} =15V, I _D =30A, V _{GS} =10V	-	8.5	-	nC
Q_gd	Gate-Drain("Miller") Charge		-	7.5	-	nC
td(on)	Turn-on Delay Time		-	7.5	-	ns
tr	Turn-on Rise Time	V _{DS} =15V, I _D =30A, R _{GEN} =3Ω, V _{GS} =10V	-	14.5	-	ns
td(off)	Turn-off Delay Time		-	35.2	-	ns
t _f	Turn-off Fall Time		-	9.6	-	ns
IS	Maximum Continuous Drain to Source Diode Forward Current		-	-	70	А
ISM	Maximum Pulsed Drain to Source Diode Forward Current		-	-	280	А
VSD	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _S =30A	-	-	1.2	V

Electrical Characteristics (TJ=25°C, unless otherwise noted)

Note :

1、The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.

 $2 \ensuremath{\, \mathrm{N}}$ The data tested by pulsed , pulse width .The EAS data shows Max. rating .

3、The test cond \leq 300us duty cycle \leq 2%, duty cycle ition is VDD=24VGS=10V,L=0.1mH,IAS=15A

4、The power dissipation is limited by 175°C junction temperature

5. The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation.



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Figure 5: Gate Charge Characteristics



Figure 2: Typical Transfer Characteristics







Figure 6: Capacitance Characteristics



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Figure 7: Normalized Breakdown Voltage vs. Junction Temperature



Figure 9: Maximum Safe Operating Area vs. Case Temperature



Figure 8: Normalized on Resistance vs Junction Temperature



Figure 10: Maximum Continuous Drain Current







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